

Realizes high-precision and high-reliability oxide film microfabrication. Parallel Plate Type Etching System

<CCP—T60M/B2M>



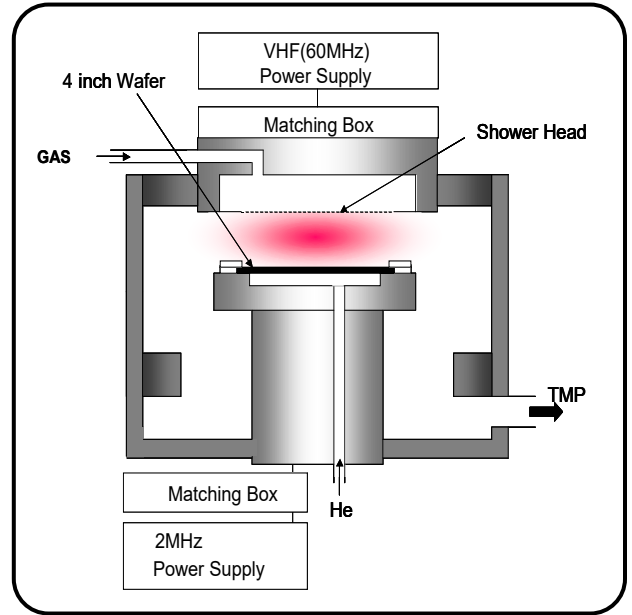
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- Selective generation of radicals from process gas
- Low electron temperature and high Density Plasma can be obtained.
60MHz power is applied to the upper electrode.
→ 2 MHz applied to the lower electrode for high-density control of ion energy. (Optional)
- Built-in sequencing program to maintain optimal etching process conditions at all times
→ A cleaning process (O_2) in the etching process removes fluorine-based film from the electrodes and chamber walls.

What is CCP type plasma etching system?

Low-k etching using SiO₂ contact holes, SiOCH and organic materials for ultra-large scale integrated circuits (ULSI) Plasma etching technology that introduces Freon gas into the parallel plate plasma mechanism enables high-precision etching of nano-level, we have been performing high-precision nano dimensional processing by plasma etching technology that introduces a Various methods are used in plasma etching systems. The parallel plate etching system is the world standard for silicon-based oxide film etching using CFC-based gases.

Schematic diagram



Standard specification

External dimensions(control system · Excluding gas systems)···W2,000mm × D2,000mm × H2,000mm

I) CCP Type 2 Frequency Etching Machine			II) Load Lock Chamber		
Process Chamber	Material	SUS304	Chamber	Material	SUS304
	Size	φ 300×H300mm		Substrate Size	φ 4 inch 1sheet
	Wall heater	RT~100°C		Conveyance system	Automatic transport
	Supported board sizes	φ 4 inch 1sheet		Vacuum pump	TMP(50ℓ/s) + RP
Board Stage	Ultimate vacuum	10 ⁻² Pa range	Exhaust system	Vacuum gauge	Ionization vacuum gauge
	Cooling method	Refrigerant circulation and Helium		attached	High vacuum angle valve
	Refrigerant temperature used	-20~60°C			Piping, etc.
	Board retention	Electrostatic chuck	III) Gas supply system		
Upper electrode	RF Bias	2MHz 500W	Gas supply system	Number of systems	Process Gas 5system N ₂ purge 1system
	RF Power Supply	60MHz 1000W		others	Valves, piping, etc. 1set
	Electrode	Shower head electrode with cooling function	IV) Chiller unit		
Vacuum exhaust system	Refrigerant temperature used	20~60°C	Bottom cooling	Cooling capacity	1000W
	Vacuum pump	TMP(800ℓ/s) + Dry pump		Temperature control range	-20~200°C
	Vacuum gauge	Ionization vacuum gauge	Top cooling	Cooling capacity	500W
	Pressure control	Capacitance manometer		Temperature control range	20~60°C
Control system	Interlock	Equipped	© Other options		
	Power supply control panel	PLC control, touch panel system	<ul style="list-style-type: none"> · Emission spectrograph · Feedback control interface, etc. 		

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